

# On the application of radio frequency voltages to ion traps via helical resonators

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**Abstract** Ions confined using a Paul trap require a stable, high voltage and low noise radio frequency (RF) potential. We present a guide for the design and construction of a helical coil resonator for a desired frequency that maximises the quality factor for a set of experimental constraints. We provide an in-depth analysis of the system formed from a shielded helical coil and an ion trap by treating the system as a lumped element model. This allows us to predict the resonant frequency and quality factor in terms of the physical parameters of the resonator and the properties of the ion trap. We also compare theoretical predictions with experimental data for different resonators, and predict the voltage applied to the ion trap as a function of the  $Q$  factor, input power and the properties of the resonant circuit.

## 1 Introduction

Trapped ions are a powerful tool which have many applications such as mass spectrometry [1] and frequency standards [2, 3], whilst also being recognised as a leading contender for the practical implementation of quantum information processing [4–6] and quantum simulations [7–10]. To trap ions within a Paul trap, a high radio frequency voltage is applied to electrodes in order to provide the required electric potential. A helical resonator allows impedance matching between a radio frequency source and an ion trap, enabling high voltages while reducing the noise injected into the system. These properties make the resonator an important device not only in ion trapping but also in a wide range

of physical sciences including ultra high frequency (UHF) mobile communication systems [11], spin resonance spectroscopy [12] and measuring the dielectric properties of materials [13].

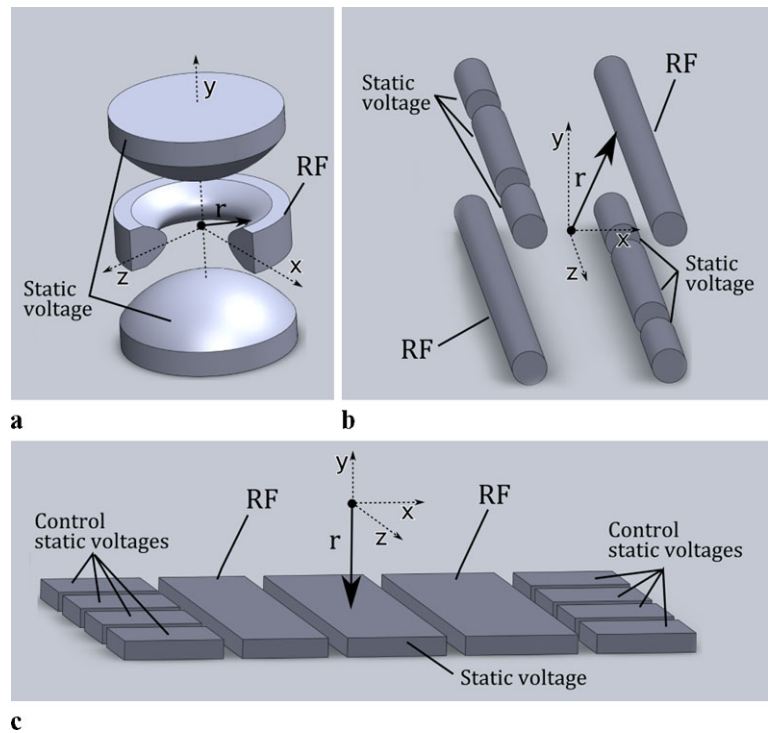
An empirical study of shielded helical coil resonators was performed by Macalpine and Schildknecht [14] who considered isolated operation at a self-resonant frequency due to the coil inductance and shield capacitance. In contrast, we consider a shielded helical coil connected to an ion trap where the resonant frequency will be determined by the whole system. Macalpine and Schildknecht [14] showed that, when tuning a resonator with an external capacitance, the  $Q$  factor would vary with the tuned resonant frequency, however, they did not predict this resonant frequency or the effect of a lossy (resistive) capacitance on the  $Q$  factor. Due to these limitations, when connecting an ion trap to a helical resonator the predictions of Macalpine and Schildknecht [14] for the resonant frequency and  $Q$  factor can deviate by orders of magnitude from those observed. In this paper, we will provide reliable predictions for the resonant frequency and  $Q$  factor for a shielded helical coil connected to an ion trap impedance. We also provide a design guide which allows a helical resonator to be constructed with the highest possible  $Q$  factor for the constraints of a particular experiment. We also discuss the process of impedance matching with a helical resonator and predict the voltage applied to the ion trap as a function of the  $Q$  factor, input power and the properties of the resonant circuit.

## 2 Trapping charged particles

Paul traps [1], which are a prime candidate for quantum information processing [4–6], trap ions using a radio frequency (RF) voltage applied to some of the trap electrodes

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**Fig. 1** (a) Diagram showing a quadrupole Paul trap. The ponderomotive potential due to the RF and ground electrodes provide confinement in all three dimensions. All electrodes are hyperbolically shaped. (b) A two-layer linear Paul trap with two rod RF electrodes and two segmented RF ground electrodes providing transverse confinement with static voltages present to provide confinement in the axial dimension. (c) Diagram showing a five-wire surface Paul trap. Here the ion is confined in a potential created by the surface electrodes at the mid-point between the two RF strips. Control static voltage electrodes are present to enable confinement along the axial direction of the trap. This enables ions to be transported along the length of the trap [17]



in order to obtain a suitable ponderomotive pseudopotential. Figure 1 shows examples of different types of Paul trap designs. The potential used to trap an ion of mass,  $m$ , and charge,  $e$ , is given by [15, 16]

$$\psi = \frac{e^2 V_0^2 \eta^2}{4mr^4 \Omega_{\text{rf}}^2} (x^2 + y^2), \quad (1)$$

where  $\Omega_{\text{rf}}$  is  $2\pi$  times the RF frequency in hertz (throughout the text, when analysing the overall resonant circuit we will refer to  $\Omega_{\text{rf}}$  as  $\omega$  or  $\omega_0$  when the circuit is on resonance),  $r$  is the distance from the centre of the trap to the nearest electrode and  $V_0$  is the amplitude of the RF voltage applied to the trap.  $\eta$  is a geometric efficiency factor [16] which is equal to one for a perfectly hyperbolic geometry (similar to the trap shown in Fig. 1(a)) and less than one as the geometry strays from this perfect form.

The secular frequency of an ion trapped inside the ponderomotive pseudopotential, given in (1), is then given by [15, 16]

$$\omega_s = \frac{eV_0\eta}{\sqrt{2}mr^2\Omega_{\text{rf}}}. \quad (2)$$

Linear ion traps (as seen in Fig. 1(b) and (c)) possess a linear node in the produced ponderomotive potential. To provide ion confinement along this node, additional static voltages are applied to certain electrodes. The equations of motion for an ion inside this potential are given by the Mathieu equations [1], which feature stability parameters.

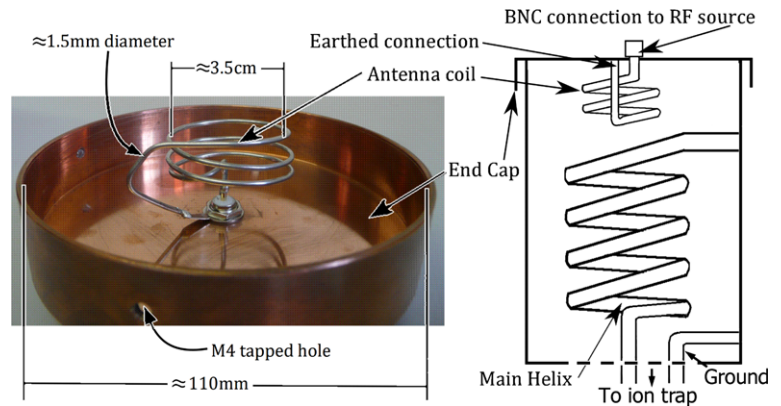
Stable motion of an ion in the trapping field will only occur over certain ranges of these parameters and is dependent on the initial position and momentum of the ion. It can be seen from (1) and (2) that a high voltage will lead to a deep trapping potential and a high secular frequency. A deep potential provides long ion lifetimes and large secular frequencies typically allow for faster ion transportation [17], more efficient ground state cooling and shorter quantum gate times.

The application of high voltages must, however, be limited to avoid both electrical breakdown or experimentally intrusive temperatures due to the power dissipated in the ion trap. It is important to know the voltage being applied to the ion trap for a given input power. A combined ion trap-resonator system can be represented as a series LCR circuit with resonant frequency  $\omega_0 = \frac{1}{\sqrt{LC}}$  and  $Q = \frac{1}{R}\sqrt{\frac{L}{C}}$ . The voltage over the ion trap will be approximately equal to the voltage over the capacitor when the capacitance of the ion trap dominates the overall capacitance of the circuit. At resonance the peak voltage over the capacitor is equal to the peak voltage over the inductor. The instantaneous voltage of the inductor is

$$V(t) = L \frac{dI_{\text{peak}} \sin(\omega_0 t)}{dt} = L\omega_0 I_{\text{peak}} \cos(\omega_0 t), \quad (3)$$

where  $I_{\text{peak}}$  is the peak current and  $L$  is the coil inductance. The peak voltage over the inductor occurs when  $\cos(\omega_0 t) = 1$ , hence the peak voltage over the ion trap can be approximated as

**Fig. 2** A resonator end cap showing the antenna coil together with a diagram showing its location in a fully constructed helical resonator



$$V_{\text{peak}} \approx LI_{\text{peak}}\omega_0. \quad (4)$$

Power is only dissipated in the system through the resistance  $R$ , thus the power dissipated is

$$P_d = RI_{\text{rms}}^2 = \frac{1}{2}RI_{\text{peak}}^2, \quad (5)$$

where  $I_{\text{rms}} = \frac{1}{\sqrt{2}}I_{\text{peak}}$  is the root-mean-square current. Using these equations and  $Q = \frac{1}{R}\sqrt{\frac{L}{C}}$ , we find that

$$V_{\text{peak}} \approx \kappa\sqrt{2PQ}, \quad (6)$$

where

$$\kappa = \left(\frac{L}{C}\right)^{\frac{1}{4}} \quad (7)$$

and

$$V_{\text{rms}} = \frac{V_{\text{peak}}}{\sqrt{2}} \approx \kappa\sqrt{PQ}.$$

This shows that the output voltage of a resonating system can be predicted given the input power,  $P$ , the capacitance,  $C$ , inductance,  $L$ , and quality factor  $Q$  of the system. Applying RF voltages via a high  $Q$  factor resonator reduces the power in unwanted frequencies being applied, reducing their contribution to motional heating of ions [18], and also provides higher voltages per input power, resulting in deeper trapping potentials and higher secular frequencies.

The impedance of the ion trap and connections are typically large enough to contribute to the response of an LCR resonator, and thus must be considered when designing a resonator to operate at a given frequency. Considering  $\omega_0 = \frac{1}{\sqrt{LC}}$  and  $Q = \frac{1}{R}\sqrt{\frac{L}{C}}$ , in order to maximise the  $Q$  factor for a fixed frequency  $\omega_0$  we must minimise  $C$  while maximising  $L$ . The use of a helical coil allows for an inductor to be made with a low self-capacitance and resistance, enabling the resistance and capacitance of the ion trap and connections to dominate the  $R$  and  $C$  of the LCR resonator and thus maximising the  $Q$  factor.

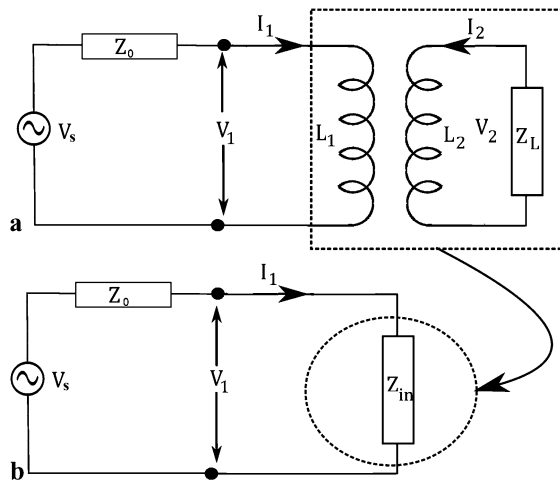
### 3 Circuit model

#### 3.1 Impedance matching via inductive coupling

RF voltages can be applied by direct connection from the ion trap to an RF amplifier; however, this can cause multiple issues. A mismatch of impedance between the amplifier and the ion trap will cause the RF signal to be reflected from the ion trap, resulting in power dissipated over the output impedance of the amplifier. This will require an RF amplifier with a much greater power handling than for a matched system. The amplifier will also inject noise into the ion trap which can cause heating of the ion [18]. Passing the output of the amplifier through a resonator will filter this noise, reducing the contribution to ion heating. In order to maximise the filtering of this noise, the resonator must have a high  $Q$  factor, and hence a narrow bandwidth. Direct connection of a resonator to the amplifier will reduce the resonator's  $Q$  factor due to the damping effect of the finite output impedance of the amplifier. The RF amplifier can, however, be connected to the resonator through a capacitive or inductive coupling, which decouples the resonator from the resistive output impedance of the amplifier, allowing for a resonator with a high  $Q$  factor. This technique also allows impedance matching of the ion trap and RF amplifier by altering the coupling, thus reducing the reflected power, and hence the required power for a given voltage.

For inductive coupling an antenna coil is attached to an end cap and placed directly and centrally above the main helical coil as shown in Fig. 2. By altering the physical properties of this coil, impedance matching between the resonator and the radio frequency source can be achieved.

To understand how altering the physical properties of the antenna coil allows impedance matching, the resonator is represented by two electrically isolated circuit loops as shown in Fig. 3. Here the inductor,  $L_1$ , represents the antenna coil and the inductor,  $L_2$ , represents the main coil. The voltage source  $V_s$  and impedance  $Z_0$  represent the output of an RF amplifier. The two coils are placed in close proxim-



**Fig. 3** (a) Circuit of a resonator with attached load (*inside dashed box*) and signal generator (*outside dashed box*) represented as two physically separate circuit loops coupled together by the antenna coil inductor,  $L_1$ , and the main coil inductor,  $L_2$ . The impedance of the ion trap is shown as a load impedance,  $Z_L$ . The source voltage and impedance (*outside dashed box*) are shown as  $V_s$  and  $Z_0$ , respectively. (b) The circuit from (a) is represented as the Thévenin equivalent impedance,  $Z_{in}$ , along with the source voltage and impedance

ity to each other creating a coupling between the two circuit loops due to the mutual inductance.

The voltage in each circuit loop is given by

$$V_{1/2} = i\omega L_{1/2} I_{1/2} + i\omega M I_{2/1}, \quad (8)$$

where  $M = k\sqrt{L_1 L_2}$  is the mutual inductance of the two coils and  $k$  is the coupling. The equivalent circuit is given in Fig. 3(b) where the impedance  $Z_{in}$  describes the overall impedance of the resonator (and ion trap), which can be adjusted by altering the physical parameters of the antenna coil enabling an impedance match to the RF amplifier ( $V_s$  and  $Z_0$ ). The overall impedance,  $Z_{in}$ , of the two circuits, as shown in Fig. 3, is then

$$Z_{in} = V_1/I_1 = i\omega L_1 + i\omega M \frac{I_2}{I_1}. \quad (9)$$

Using

$$V_2 = -Z_L I_2 \quad (10)$$

and (8), we obtain

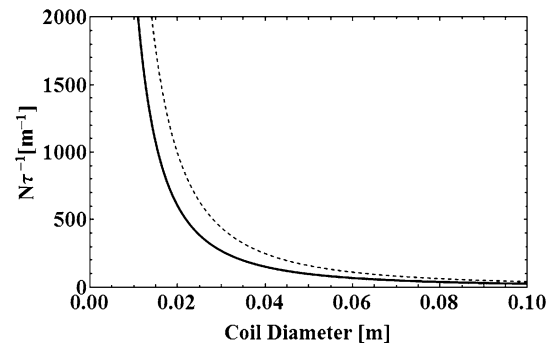
$$(Z_L + i\omega L_2)I_2 + i\omega M I_1 = 0. \quad (11)$$

Rearranging (11) for  $I_2/I_1$  gives

$$\frac{I_2}{I_1} = \frac{-i\omega M}{Z_L + i\omega L_2}. \quad (12)$$

Inserting (12) into (9), we can describe the overall impedance as

$$Z_{in} = i\omega L_1 + \frac{\omega^2 M^2}{i\omega L_2 + Z_L}. \quad (13)$$



**Fig. 4** The ratio of number of antenna turns  $N$  to winding pitch  $\tau$ , required to impedance match the load to a 50 ohm source is plotted as a function of the antenna coil diameter. This is shown for the case when the combined resonator–ion trap load is high (solid black line, a resistance of 15 ohm and a capacitance of 100 pF), and for the case when the load is small (dashed black line, a resistance of 0.2 ohm and a capacitance of 1 pF). In both cases, a resonant frequency of  $\omega = 2\pi \times 20$  MHz is used

We can approximate the antenna coil's inductance as  $L_1 = \frac{\mu_0 N A}{\tau}$ , where  $\tau$ ,  $N$  and  $A$  are the winding pitch, number of turns and cross-sectional area of the coil, respectively, and  $\mu_0$  is the permittivity of vacuum, giving

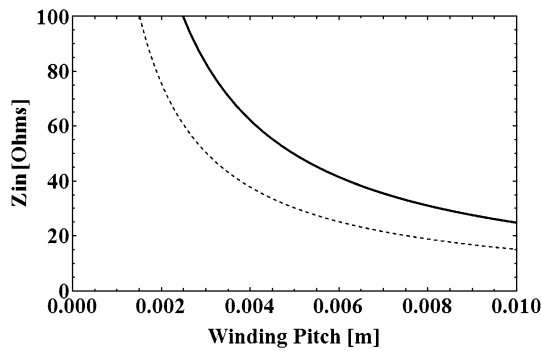
$$Z_{in} = \frac{\mu_0 N A}{\tau} \left( i\omega + \frac{k^2 L_2 \omega^2}{i\omega L_2 + Z_L} \right). \quad (14)$$

This shows that the input impedance of the resonator can be altered by simply adjusting the physical parameters of the antenna coil and, thus, match it to that of the voltage source. To illustrate how the physical parameters have to be altered to achieve a matching, (14) has been plotted for two common cases. The first case (solid black line) is when the combined resonator–ion trap load is high (a resistance of 15 ohm and a capacitance of 100 pF) and the second (dashed black line) when the load is small (a resistance of 0.2 ohm and a capacitance of 1 pF). In both cases, the traps are driven at a frequency of  $\omega = 2\pi \times 20$  MHz. Figure 4 shows the ratio of number of antenna turns to winding pitch as a function of the diameter of the coil required to impedance match the load to a 50 ohm source. Figure 5 then illustrates how an existing antenna coil can be physically stretched (increasing the winding pitch of the coil) to impedance match to a source load. In Fig. 5, the number of turns is kept constant at 3 and the diameter is kept constant at 3 cm.

Figure 5 shows that in order to impedance match a source to a high impedance trap load (solid line) the antenna coil must be stretched compared with that required to match a low impedance trap load (dashed line).

### 3.2 Description of resonant frequency and $Q$ factor using an LCR circuit model

In order to calculate the  $Q$  factor and resonant frequency  $\omega_0$ , the resonator is modelled as a lumped element circuit, shown



**Fig. 5** The resonator input impedance,  $Z_{in}$ , is shown as a function of the winding pitch,  $\tau$ , of the antenna coil. This is shown for the case of a high combined resonator-ion trap load ( $Z_L$  given by a resistance of 15 ohm and a capacitance of 100 pF) shown by the *solid black curve* and for the case of a small load ( $Z_L$  given by a resistance of 0.2 ohm and a capacitance of 1 pF) shown by the *dashed black curve*. In both cases, a resonant frequency of  $\omega = 2\pi \times 20$  MHz is used and the number of turns and coil diameter are kept constant at 3 and 3 cm, respectively

in Fig. 6(a), which is simplified via Fig. 6(b) to Fig. 6(c) by creating Thévenin equivalent impedances, where each component is defined in the table in Fig. 6(d).

The coil impedance will depend on the mutual coupling,  $Z_M$ , which can be written as

$$Z_M = iX_{L_c} + \frac{\omega^2 M^2}{i\omega L_a + Z_0} \quad (15)$$

by using the same method employed to arrive at (13), where  $X_{L_c} = L_c\omega$  is the reactance due to the inductance of the main coil. However, with the typical values required by ion trapping of RF drive frequency between  $\omega \approx 2\pi \times 10$  MHz and  $2\pi \times 50$  MHz,  $L_c \approx L_a \approx 1$  mH and  $Z_0 = 50$  ohm, it can be shown that  $|Z_M| \approx iX_{L_c}$ . Thus, we can express:

$$Z_{coil} = \left( \frac{1}{iX_{L_c} + R_c} + \frac{1}{iX_{C_c}} \right)^{-1}. \quad (16)$$

Summing the trap capacitance and resistance in parallel with the wire capacitance and shield capacitance, we can write the  $Z_E$  impedance as

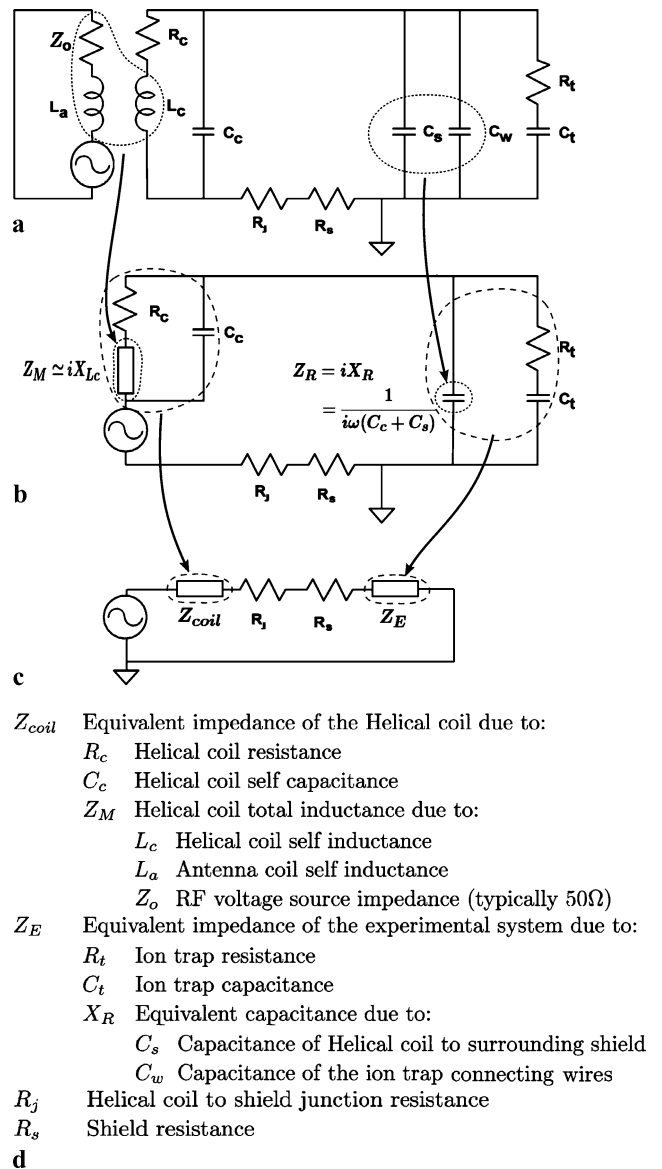
$$Z_E = \left( \frac{1}{iX_{C_t} + R_t} + \frac{1}{iX_{C_w}} + \frac{1}{iX_{C_s}} \right)^{-1}, \quad (17)$$

where  $X_{C_t} = \frac{1}{C_t\omega}$  is the reactance of the trap capacitance and  $X_{C_w}$  and  $X_{C_s}$  are the reactance due to  $C_w$  and  $C_s$ , respectively.

The total impedance of the resonator,  $Z_{tot}$ , can then be expressed as

$$Z_{tot} = Z_{coil} + Z_E + R_s + R_j. \quad (18)$$

We can express both  $Z_{coil} = R_{coil} + iX_{coil}$  and  $Z_E = R_E + iX_E$ , where  $R_{coil}$  and  $R_E$  are the equivalent series resistance of the coil and experimental system, respectively, and  $X_{coil}$  and  $X_E$  are the equivalent series reactance for



**Fig. 6** Diagram showing the electrical equivalent of the overall resonant circuit. Part (a) shows the lumped element model electrical equivalent. Part (b) shows the simplified circuit. Part (c) shows the set of serial impedances the resonator can be represented as

the coil and experimental system, respectively. **At resonance  $Z_{tot}$  will be purely resistive when**

$$X_{coil} + X_E = 0. \quad (19)$$

From the calculated Thévenin equivalent impedances from Fig. 6 it can be shown that at resonance,

$$\frac{i\omega_0 L_c}{1 - L_c C_c \omega_0^2} + \frac{1}{i\omega_0 (C_s + C_t + C_w)} = 0. \quad (20)$$

This equation can be used to calculate the resonant frequency:

$$\omega_0 = \frac{1}{\sqrt{(C_s + C_t + C_w + C_c)L_c}}. \quad (21)$$



The  $Q$  factor is defined as  $Q \equiv \omega_0 \frac{\text{Energy stored}}{\text{Power dissipated}}$ . The energy stored in the resonator will oscillate between the inductance of the coil and the combined capacitances in the circuit. The total energy stored will be equal to the peak energy stored in the inductor  $E_{L_c} = I_{\text{peak}}^2 L_c / 2 = I_{\text{rms}}^2 L_c$  and the power dissipated in the system is  $P_d = I_{\text{rms}}^2 R_{\text{ESR}}$  where  $R_{\text{ESR}}$  is the equivalent series resistance of the circuit and is given by the real part of (18). It can then be shown that the  $Q$  factor of a resonator is given by the following:

$$Q = \frac{X_{L_c}}{R_{\text{ESR}}} \quad (22)$$

From (18),  $R_{\text{ESR}}$  can be derived as

$$R_{\text{ESR}} = \frac{R_c X_{C_c}^2}{R_c^2 + (X_{C_c} + X_{L_c})^2} + \frac{R_t X_R^2}{R_t^2 + (X_R + X_T)^2} + R_s + R_j \quad (23)$$

For helical coils with a low self-capacitance ( $X_{L_c} \ll X_{C_c}$ ) and low resistance ( $R_c \ll X_{C_c}$ ), and for an ion trap with low resistance such that  $R_t \ll (X_{C_t} + X_{C_w} + X_{C_s})$ , this can be approximated as

$$R_{\text{ESR}} \simeq R_j + R_c + R_s + R_t \alpha^2, \quad (24)$$

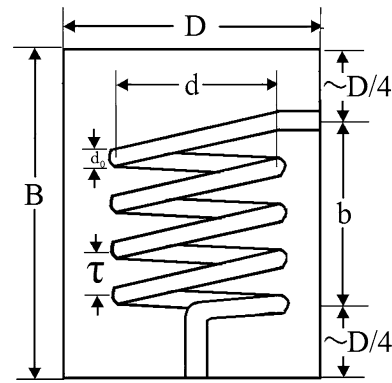
where  $\alpha = \frac{a}{a+1}$ ,  $a = \frac{X_R}{X_T} = \frac{C_t}{C_s + C_w}$  is the ratio of the trap capacitance to the combined capacitance due to the connecting wires and coil shield. For  $a \rightarrow 0$  the capacitance of the shield and wires shunt the RF current, and there is negligible contribution from the resistance of the ion trap. For  $a \rightarrow \infty$  the trap capacitance dominates, giving a maximum contribution of the ion traps resistance.

It should be noted that, as high  $Q$  factors are obtained when maximising the coil inductance and minimising the system capacitance, the effect of wire and feed-through inductance will be negligible compared to a typical coil inductance and, as such, has not been included in the model. This is not true of stray capacitances which can be on the same order of magnitude as the ion trap capacitance and can be treated as part of the wire capacitance  $C_w$ .

### 3.3 Resonator capacitance, inductance and resistance

In order to construct a resonator to operate at a desired frequency, the capacitance of the wires and ion trap  $C_\Sigma = C_w + C_t$ , which depend on the configuration of the ion trap and experimental setup, can be measured at the vacuum systems feed-through with a capacitance meter. Once these are known, we must construct a shielded coil, as shown in Fig. 7, with the necessary capacitance  $C_c$  and  $C_s$  and inductance  $L_c$ . All equations in this section assume the use of SI units unless otherwise stated. The self-capacitance of the coil in units of farads, given empirically by Medhurst, is [19]

$$C_c \simeq (Hd) \times 10^{-12}, \quad (25)$$



**Fig. 7** Outline design of a resonator, showing the shield diameter  $D$ , shield height  $h$ , coil diameter  $d$ , coil height  $b$ , winding pitch  $\tau$  and the coil wire diameter  $d_0$

where  $d$  is the diameter of the coil and  $H$  is given empirically by,  $H = 11.26 \frac{b}{d} + 8 + \frac{27}{\sqrt{b/d}}$  F/m.

The capacitance present between the coil wire and the outer shield in units of farads is given empirically by [14]

$$C_s \approx b K_{C_s}(d, D), \quad (26)$$

where

$$K_{C_s}(d, D) = 39.37 \frac{0.75}{\log(\frac{D}{d})} \times 10^{-12} \text{ F/m},$$

$d$  is the diameter of the coil,  $D$  the inner shield diameter and  $b$  is the height of the coil.

The inductance of a coil inside a shield in units of henrys, for  $b/d \geq 1$ , is given empirically by [14]

$$L_c \approx b K_{L_c}(d, D, \tau), \quad (27)$$

where

$$K_{L_c}(d, D, \tau) = 39.37 \frac{0.025 d^2 (1 - (\frac{d}{D})^2)}{\tau^2} \times 10^{-6} \text{ H/m}$$

and  $\tau$  is the winding pitch of the coil.

We can approximate the required height of a coil,  $b$ , for a resonator to operate at frequency  $\omega_0$ , for chosen parameters of  $d$ ,  $D$  and  $\tau$  and for a set of measured capacitances  $C_\Sigma = C_w + C_t$ . The coil's self-capacitance, given by (25), significantly complicates the solution for coil height,  $b$ ; however, a simpler solution can be found by approximating the self-capacitance as a linear equation. Examining (25), it can be seen that the maximum of the nonlinear term  $\frac{27}{\sqrt{b/d}}$  occurs when  $b/d < 1$ . As we require that  $b/d \geq 1$ , a simple linear approximation for the coil self-capacitance can be found by setting the  $\sqrt{b/d}$  term to 1. This gives an overestimate of the self-capacitance but allows for an approximate solution for the coil height which will give a resonator with a resonant frequency typically within 2% of the desired frequency. The linear approximation to the coil self-capacitance is,  $C_c \simeq K_{cb}b + K_{cd}$ , where  $K_{cb} = 11.26 \times 10^{-12}$  F/m and  $K_{cd} = 35d \times 10^{-12}$  F. Substituting this approximation with

(27) and (26) into (21) and rearranging for  $b$  in units of metres, we obtain:

$$b \simeq \frac{C_\Sigma + K_{cd}}{K_{Cs} + K_{cb}} \times \left( \sqrt{\frac{K_{Cs} + K_{cb}}{(C_\Sigma + K_{cd})^2 K_{Lc} \omega_0^2} + \frac{1}{4}} - \frac{1}{2} \right) \text{ m.} \quad (28)$$

In order to estimate the resistance of the resonator, one must consider the path along which the current flows and how it flows along this path. The current will flow along the surface on its path with a depth,  $\delta$ , given by the skin depth of the coil material (in this case, copper) at the resonant frequency of the resonator. However, additionally, the current in the shield must form a spiral which acts to form an equal and opposite magnetic field as that produced by the coil (Lenz's law). The distance around the shield the current will travel,  $l_s$ , can be calculated by equating the magnetic field, created by the coil at the shields surface:

$$B_{\text{field}} = \frac{\mu I l_c}{4\pi(D-d)^2}, \quad (29)$$

to that created by the shield  $B_{\text{shield}}$ :

$$B_{\text{shield}} = \frac{\mu N_s I}{b}, \quad (30)$$

where  $l_c$  is the unwound length of the coil.

This can then be solved to find the number of turns the current undergoes in the shield,  $N_s$ :

$$N_s = \frac{b l_c}{4\pi(D-d)^2}. \quad (31)$$

The distance the current will travel from the bottom of the shield to the top of the shield can then be calculated as

$$l_s = N_s \sqrt{(\pi^2 D^2) + \left(\frac{b}{N_s}\right)^2}. \quad (32)$$

The resistance of the coil and the shield can now be calculated using the relationship between resistance,  $R$ , and resistivity,  $\rho$ :

$$R = \frac{\rho l_s}{A}, \quad (33)$$

where  $l$  is the length along which the current travels and  $A$  the area through which the current travels. We can now describe the resistance of the coil and shield as

$$R_c = \frac{\rho l_c}{d_0 \pi \delta}, \quad (34)$$

$$R_s = \left( \frac{N_s \rho l_s}{b \delta} \right), \quad (35)$$

where  $d_0$  is the diameter of the coil wire.

We must also take into account additional resistances acquired by attaching the coil to the shield. The coils in this paper are attached to the shield by soldering them onto a

BNC bulkhead located at a distance  $\frac{D}{4}$  from the top of the shield as indicated in [14] and Figs. 7 and 12. The solder joint created by this method will provide an additional resistance. The resistance of the connection at an angular frequency,  $\omega_n$ , is given by

$$R_n = \frac{\rho l}{\pi d_j \delta_n}, \quad (36)$$

where  $\rho$  is the resistivity of the material,  $l$  is the length through which the current flows,  $\delta_n$  is the skin depth at an angular frequency  $\omega_n$  and  $d_j$  is the diameter of the solder joint. Due to the effects of skin depth at high frequencies, a simple DC resistance measurement of the joint connecting the coil to the shield is not useful. Instead, an AC resistance measurement must be made of the joint. Equipment exists (for example, ISO-TECH: LCR819) which can perform resistance measurements at frequencies of approximately 100 kHz and this measurement can then be used to infer the resistance of the joint at a higher frequency, in this case the resonant frequency of the resonator. The measurement frequency needs to be chosen so that the skin depth is smaller than the radius of the joint. By defining  $\gamma = (\rho l)/(\pi d_j)$ , (36) can be rewritten as

$$R_n = \frac{\gamma}{\delta_n}. \quad (37)$$

By using the frequency independent parameter,  $\gamma$ , it is possible to show for two different angular frequencies,  $\omega_1$  and  $\omega_2$ ,

$$R_1 \delta_1 = R_2 \delta_2, \quad (38)$$

and rearranging using  $\delta_n = 2\sqrt{(\rho)/(\omega_n \mu_0)}$  gives the resistance at a resonant angular frequency  $\omega_0$  in terms of the resistance measured at an angular frequency  $\omega_1$ :

$$R_0 = R_1 \sqrt{\frac{\omega_0}{\omega_1}}. \quad (39)$$

This derivation is only valid in a frequency regime where the solder joint is larger than the skin depth and when the resistivity,  $\rho$ , of the material is constant over the two frequencies used. This is the case for the resonators made in this paper as the skin depth is of the order of 10  $\mu\text{m}$  and the solder joint size is on the order of a few millimetres.

Equation (39) shows that by taking a resistance measurement at one frequency it is possible to calculate the resistance at another frequency. This method was used to calculate the resistance of the connection made between the main coil and the shield at the resonators resonant frequency.

## 4 Resonator design guide and analysis

### 4.1 Design guide

This section will provide a design guide which will enable a helical resonator to be constructed with a  $Q$  factor close to

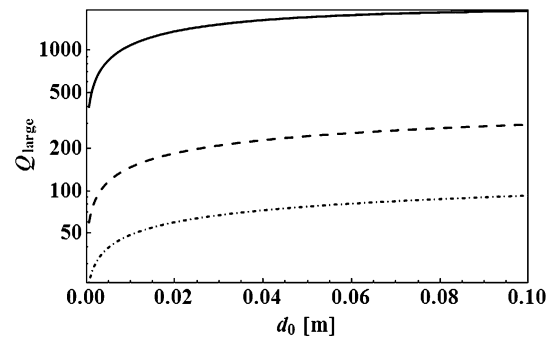
that of the highest  $Q$  possible for a given set of parameters consisting of the desired resonant frequency,  $\omega_0$ , ion trap capacitance,  $C_t$ , and resistance,  $R_t$ , wire capacitance,  $C_w$ , and the size constraints for the resonator. The helical resonator may require different construction techniques depending on priorities set by these constraints; however, there are some design issues universal to any resonator that must be considered.

When designing a resonator, it is important that certain constraints are met for the resonant frequency and  $Q$  factor to be predicted by the theory. The resonant frequency depends on the inductance, which is predicted by (27). For this equation to be valid, the coil height should be greater than the coil diameter,  $b \geq d$ , and the coil diameter should be greater than the wire diameter,  $d \geq d_0$ .

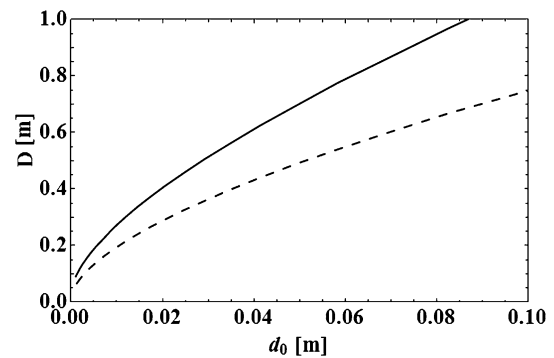
We can see from (27) that both the coil diameter and the winding pitch have a strong ( $d^2$  and  $1/\tau^2$ ) effect on the inductance. It is important to ensure the coil is made with precision for the winding pitch and the diameter of the coil to be constant along its length. This dependence also requires that the coil is not susceptible to mechanical vibrations. The strong effect the winding pitch,  $\tau$ , has on the inductance will result in vibrations of the coil causing the inductance and hence resonant frequency of the resonator to become time dependent. In order to minimise vibrational effects, the coil should be constructed to be rigid and should be firmly mounted inside the shield. Finally, the coil must be mounted centrally inside an outer shield of height  $B \geq b + D/2$  (we would typically recommend  $B = b + D/2$ ), where  $b$  is the coil height and  $D$  is the shield diameter, in order to keep the coil fringe effects from reducing the coil's inductance and increasing the shield capacitance [20].

In order to achieve high  $Q$  factors, the resonator must be built to minimise the resistance of the shield, the coil and solder joints. The coil and shield should be made from a highly conductive material (such as copper) which is thicker than the skin depth at the desired operating frequency. Any solder joints should be made with a clean oxide free surface before soldering, with both parts of the joint reaching a sufficient temperature to ensure good solder flow between them.

A low resistance for the helical coil can be obtained by ensuring the use of a large diameter wire,  $d_0$ . The effect of the wire diameter on the  $Q$  factor can be seen by plotting the 'largest'  $Q$  factor vs wire diameter  $d_0$ . We can define the 'largest'  $Q$  factor available,  $Q_{\text{large}}$ , for a given set of parameters,  $\omega_0$ ,  $C_t$ ,  $C_w$ ,  $R_t$  and  $d_0$ , where the coil diameter,  $d$ , and shield diameter,  $D$ , are chosen to maximise the  $Q$  factor. Figure 8 shows a plot of  $Q_{\text{large}}$  vs  $d_0$  for three traps of  $C_t = 5$  pF and  $R_t = 5$  ohm,  $C_t = 20$  pF and  $R_t = 15$  ohm,  $C_t = 50$  pF and  $R_t = 15$  ohm all for a resonant frequency of  $\omega_0 = 2\pi \times 10$  MHz. There is an asymptotic increase to higher  $Q$  factors for large values of  $d_0$ . Even for high resistance, and capacitance traps modest  $Q$  factors of  $\approx 100$  can



**Fig. 8**  $Q$  factor for values of  $d$  and  $d/D$  that maximise the  $Q$  factor for varying wire diameter,  $d_0$ , for traps D (solid), H (dashed) and I (dot-dashed) from Table 1 at  $\omega_0 = 2\pi \times 10$  MHz

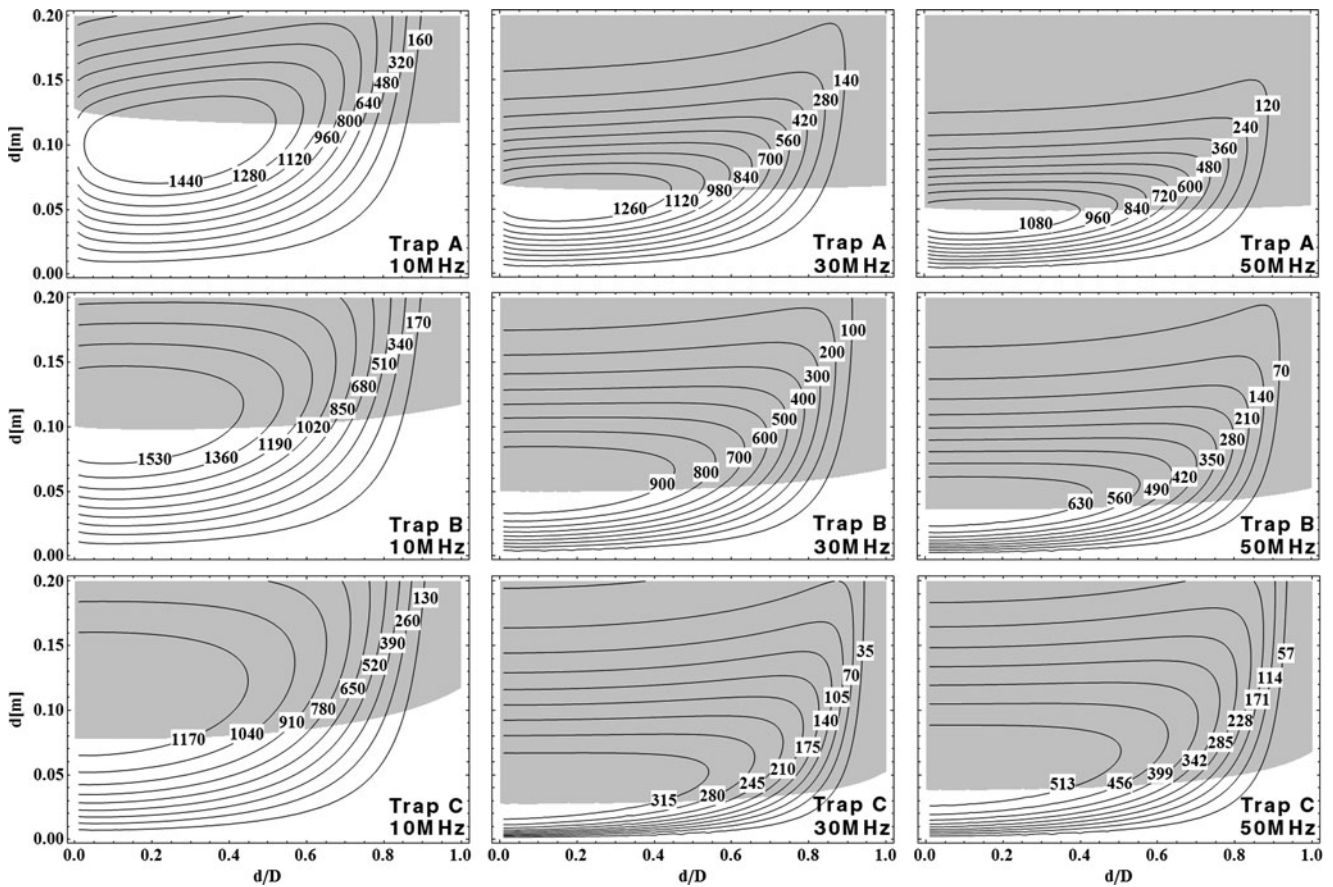


**Fig. 9**  $D$  vs  $d_0$  for the  $D$  value that achieves a  $Q$  factor of  $Q_{\text{large}}$  (solid line) and the minimum  $D$  value that achieves a  $Q$  factor of  $Q_{90\%}$  (dashed line) for trap D from Table 1 at  $\omega_0 = 2\pi \times 10$  MHz

be achieved; however, this requires the coil to be formed from a thick rod. The upper limit to  $d_0$  will result from an intersection of the limits that the coil height must be larger than the coil diameter,  $b/d \geq 1$ , and the coil diameter must be larger than the wire diameter,  $d > d_0$ . Increasing  $d_0$  will increase the  $Q$  factor but will also increase the size of the resonator. It can be seen in Fig. 9 how the shield diameter required for  $Q_{\text{large}}$  (solid line) rapidly increases with  $d_0$ . However, for a  $Q$  factor 90% of  $Q_{\text{large}}$ ,  $Q_{90\%}$ , a smaller shield diameter can be used. The minimum  $D$  for  $Q_{90\%}$  is shown in Fig. 9 (dashed line). It is clear that making a resonator with a  $Q$  factor of  $Q_{90\%}$  can reduce the size required for the resonator.

When designing a helical resonator for a specific experiment (for example a particular microfabricated ion trap [21]) it is useful to examine contour plots of the  $Q$  factor as a function of coil diameter,  $d$ , and the ratio of the coil diameter to the shield diameter,  $d/D$ , as shown in Figs. 10 and 11. Using these plots, it is possible to choose values of  $d$  and  $d/D$  that will optimise the  $Q$  factor for a set of parameters. These plots can be obtained using the parameters for  $\omega_0$ ,  $C_t$ ,  $C_w$ ,  $R_t$  for a given experiment and choosing values of  $d_0$ ,  $\tau$  and measuring or estimating  $R_j$ . The  $Q$  factor  $Q(d, d/D)$  can be obtained by calculating:





**Fig. 10** Contour plots for traps A, B and C (specifications in Table 1) shown for operation frequencies of  $\omega_0 = 2\pi \times 10$  MHz,  $\omega_0 = 2\pi \times 30$  MHz and  $\omega_0 = 2\pi \times 50$  MHz. The grey areas indicate where  $b/d < 1$ , therefore invalidating the theory

$b(d, d/D)$ —the coil height—by using (28),  $K_{C_s}$  and  $K_{L_c}$  from (26) and (27) and  $K_{c_b}$  and  $K_{c_d}$  from the approximation for the coil capacitance.

$C_s(d, d/D)$ —the coil to shield capacitance—by substituting  $b(d, d/D)$  into (26).

$C_c(d, d/D)$ —the coil self capacitance—by substituting  $b(d, d/D)$  into (26).

$R_s(d, d/D)$ —the shield resistance—by using (35).

$R_c(d, d/D)$ —the coil resistance—by using (34).

$R_{\text{ESR}}(d, d/D)$ —the total resistance—by using (24).

$L_c(d, d/D)$ —the coil inductance—by substituting  $b(d, d/D)$  into (27).

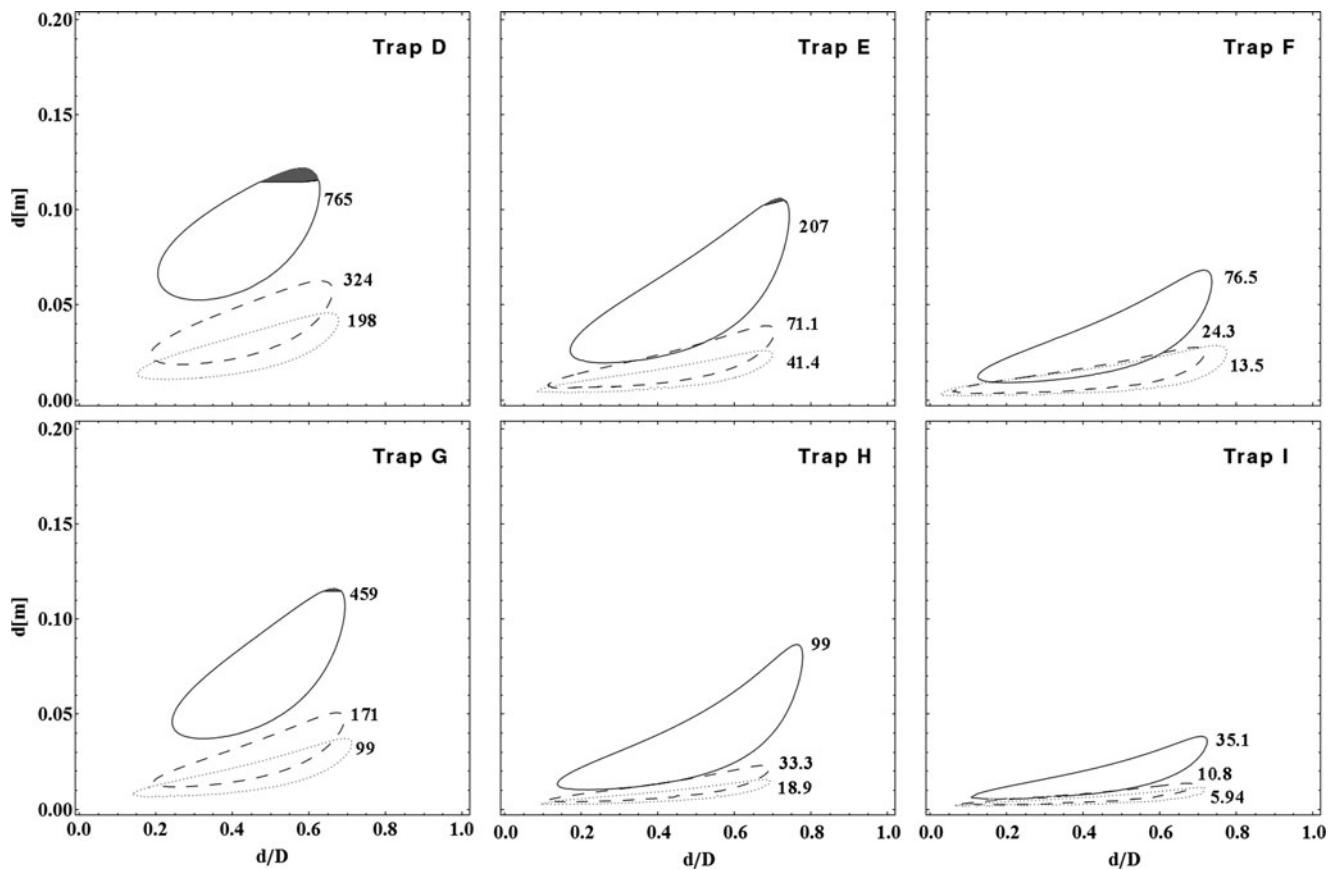
$Q(d, d/D)$ —the  $Q$  factor—by substituting  $L_c(d, d/D)$  and  $R_{\text{ESR}}(d, d/D)$  into (22).

Figures 10 and 11 show contour plots for parameters corresponding to traps from Table 1 for three resonant frequencies with  $d_0 = 5$  mm and  $\tau = 2d_0$ . While larger values of  $d_0$  would result in larger  $Q$  factors, and a larger  $Q_{\text{large}}$ , the values for  $d_0$  and  $\tau$  have been chosen as they are typical for a hand wound coil, which will be discussed in detail later. Both plots feature a grey shaded region indicating where the condition that  $b/d \geq 1$  (from (27)) is not valid. Within this

region, the coil inductance will deviate from that predicted by (27), resulting in a deviation from the predicted  $\omega_0$  and  $Q$  factor. An expansion to this theory for short helical coils or wire loops could be implemented by utilising an appropriate equation for the inductance.

The experimental size restrictions will strongly dictate the achievable  $Q$  factor of the resonator. The values of  $d$  and  $d/D$  must be chosen to ensure that the shield diameter  $D$  and the shield height  $B$  will be within these size constraints, otherwise different values for  $d$ ,  $d/D$  or  $d_0$  will need to be chosen. Figure 10 for traps A to C show contour lines at a range of  $Q$  factors (as labelled) enabling the values of  $d$  and  $D$  to be chosen to maximise the  $Q$  factor for a given size constraint. Figure 11 for traps D to I shows contour lines of  $Q_{90\%}$  for each set of parameters. The values of  $d$  and  $D$  can be chosen within the  $Q_{90\%}$  contour line to optimise the  $Q$  factor (for a set of parameters  $\omega_0$ ,  $C_t$ ,  $C_w$ ,  $R_t$ ,  $R_j$ ,  $\tau$  and  $d_0$ ), while enabling a choice of  $d$  and  $D$  that minimises the size of the resonator.

For traps A, B and C Fig. 10 shows that higher  $Q$  factors are achieved when the coil diameter to shield diameter ratio,  $d/D$ , is close to 0. This corresponds to a large separation between the coil and the shield and hence a small shield



**Fig. 11** Contour plots showing  $Q_{90\%}$  for each set of parameters corresponding to traps D to I from Table 1 for operating frequencies of  $\omega_0 = 2\pi \times 10$  MHz (solid lines),  $\omega_0 = 2\pi \times 30$  MHz (dashed lines)

and  $\omega_0 = 2\pi \times 50$  MHz (dotted lines). The grey areas indicate where  $b/d < 1$ , therefore invalidating the theory. The value of  $Q_{90\%}$  is indicated next to the contour line

capacitance. At  $d/D = 0$ , the shield diameter,  $D$ , would be infinite and the shield capacitance would be zero, indicating the resonator is dominated by the trap capacitance. However, we can see in Fig. 11 that  $Q$  factors of  $Q_{90\%}$  can be achieved at values of  $d/D$  of order 0.5 with larger trap capacitance enabling larger ratios and hence a smaller shield diameter  $D$  and higher shield capacitance.

While Figs. 8 and 9 show that at large values of  $d_0$  high  $Q$  factors may be achieved at a given size constraint, the construction of such resonators needs to be taken into account. In order to construct a resonator without specialist machinery, a wire diameter of approximately 5 mm is recommended. This wire size is sufficiently rigid not to be susceptible to mechanical vibrations, while being flexible enough when heated to be wound by hand into a coil. This can be achieved by winding the wire around a tube with notches cut into it to help align the wire to a constant winding pitch. The size of the resonator can be reduced by using a small winding pitch, however, a minimum winding pitch of  $\tau = 2d_0$  is recommended when winding by hand in order to keep the error in the winding pitch small. A higher  $Q$  factor could be achieved by using  $d_0 = 10$  mm; however, this

**Table 1** Specifications of traps used for Figs. 10 and 11

Trap	Resistance in ohm	Capacitance in pF
A	0.1	5
B	0.1	20
C	0.1	50
D	5	5
E	5	20
F	5	50
G	15	5
H	15	20
I	15	50

would be hard to wind by hand, which can result in large errors in the winding pitch.

Coils can be constructed using large diameter wire but may require the use of specialist machinery. It should be noted that coils could be constructed from tubular material as current is only carried on the skin of the metal; however, this would affect the inductance of the coil. Similarly a rect-

angular cross-section wire could be used to form a coil or formed by cutting a tube into a coil. In order to predict  $\omega_0$  and the  $Q$  factor reliably, (27) may need to be replaced with an expression for the inductance suitable for the desired geometry.

We can summarise:

- A highly conducting material should be used to construct the resonator (for example, copper).
- The coil wire should be made reasonably thick to provide mechanical stability and reduce coil resistance. If winding the coil by hand a wire on the order of  $d_0 \approx 5$  mm is suggested.
- The winding pitch should be as small and uniform as possible. If winding the coil by hand, a minimum of  $\tau \sim 2d_0$  is recommended.
- A contour plot of  $Q(d, d/D)$  can be used to determine appropriate parameters for  $d$  and  $D$  within size constraints.
- The coil height is calculated from (28).
- The coil height must be greater than the coil diameter for (27) to be valid.
- The shield height  $B$  should be  $b + D/2$ .
- The coil and shield should be connected as close to the vacuum system as possible.
- Any solder joints made should be of low resistance.

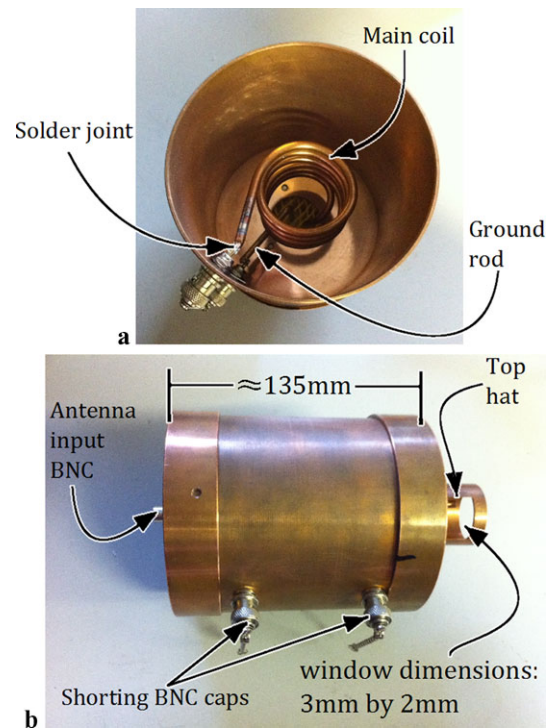
## 4.2 Case study

### 4.2.1 Resonator construction and measurement

We will now look at how resonator for a typical ion trap experiment can be built without the need for specialist equipment. We will then discuss how the resonant frequency and  $Q$  factor can be measured, while ensuring impedance matching between the RF source and the resonator.

The coil can be wound by hand by using an annealed copper wire of diameter,  $d_0 \approx 5$  mm. The copper can be annealed by heating with a blow torch in order to give increased flexibility. Once cooled the copper can be wound, which will work-harden the copper, creating a rigid coil. To ensure all the turns are equally spaced, the copper should be wound around a tube of diameter,  $d - d_0$ , with notches cut into the tube to align the wire when winding.

Once the coil is constructed, it should be placed centrally inside the shield in order to minimise the coil to shield capacitance  $C_s$ . To ensure this, it must be clamped in place at the end of the coil before soldering the coil to a BNC bulkhead located in the shield as shown in Fig. 12. This clamping must be kept in position until the joint to the BNC is solid enough to support the coil on its own. This BNC bulkhead can be used to electrically connect the coil to the shield by connecting a BNC shorting cap. The ground rod is connected in the same way although to the lower BNC bulkhead shown in Fig. 12. The ground rod must exit the resonator (as



**Fig. 12** (a) Picture showing a coil and location of the solder joint used to make an electrical connection to the shield. This is done with the use of a BNC bulkhead located at a distance  $\frac{D}{4}$  from the top of the shield where  $D$  is the diameter of the shield. The grounding rod is also shown. (b) Picture showing a fully constructed resonator. The top hat is shown on the bottom end cap and is designed to fit around a vacuum feed-through (in this case, Kurt J. Lesker: EFT 0523052) which connects the main coil and grounding rod to the ion trap. A window is cut into the top hat to allow the connection between the feed-through and the main coil and grounding rod to be made. The top end-cap shows the BNC connection to the antenna coil, this is where the RF signal is applied to the resonator

shown in Fig. 13) without coming into contact with conducting material. The ground rod and main coil can be held in place with the use of a non-conducting mesh, as shown in Fig. 13, to reduce the mechanical stress applied to them from connection to a vacuum feed-through or other similar load.

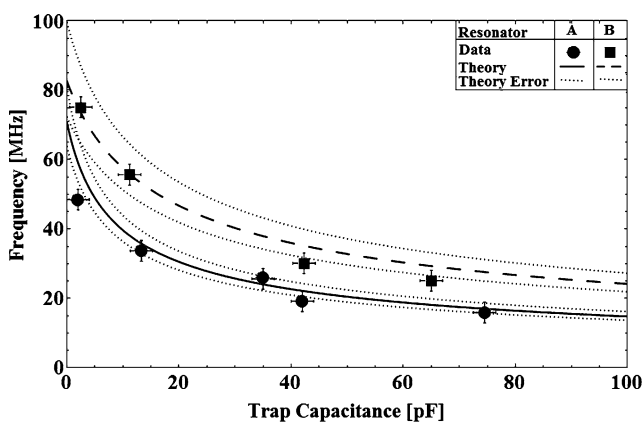
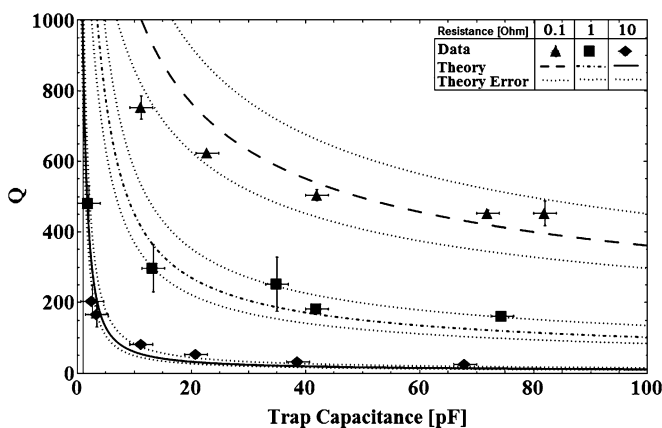
The antenna coil used to couple the radio frequency source to the resonator can be constructed out of  $1.5 \pm 0.5$  mm wire and wound into 3 turns with a winding pitch of  $10 \pm 1$  mm and diameter of  $33 \pm 1$  mm. This, however, should be varied in order to match the impedance of the resonator to the source, as described in Figs. 4 and 5 and (14). To measure the resonant frequency of the resonator, a directional coupler (for example, Mini Circuits: ZDC-20-3) should be placed between the output source port and the RF input port of a spectrum analyser's tracking generator (for example, Agilent: N9320B) as shown in Fig. 14. Alternatively, the spectrum analyser can be replaced by an RF source and an oscilloscope, as shown in grey in Fig. 14. The resonator should be connected to the directional coupler and RF source via the end-cap that hosts the antenna coil shown





**Table 2** Specifications of the resonators. The  $Q$  factors and frequencies quoted are without the addition of an ion trap load

Resonator	A	B
Shield diameter $D$ [mm]	$108 \pm 2$	$76 \pm 2$
Shield height $h$ [mm]	$120 \pm 2$	$90 \pm 2$
Coil diameter $d$ [mm]	$42 \pm 2$	$46 \pm 2$
Coil wire diameter $d_0$ [mm]	$5.0 \pm 0.1$	$5.0 \pm 0.1$
Winding pitch $\tau$ [mm]	$9 \pm 1$	$15 \pm 1$
Number of turns $N$	$6.75 \pm 0.25$	$4.5 \pm 0.25$
$d/D$ ratio	$0.4 \pm 0.2$	$0.6 \pm 0.2$
Predicted frequency [MHz]	$64^{+8}_{-6}$	$78^{+10}_{-7}$
Measured frequency [MHz]	$67 \pm 0.5$	$83 \pm 0.5$
Predicted $Q$	$1970^{+252}_{-374}$	$689^{+46}_{-115}$
Measured $Q$	$2176 \pm 200$	$631 \pm 60$

**Fig. 15** The resonant frequencies of resonator A (circles) and resonator B (squares) are shown as a function of the trap capacitance they are attached to. The dashed curves represent the error on this calculation based on the design errors stated in Table 2. The resonant frequencies were measured for a resistance of 1 ohm; however, we note that they are actually independent of the resistance**Fig. 16** The  $Q$  factor of resonator A (left) and resonator B (right) are shown as a function of the trap capacitance. The dashed curves represent the error of the calculation based on the design errors stated in Table 2. The  $Q$  factor was measured for different resistance loads

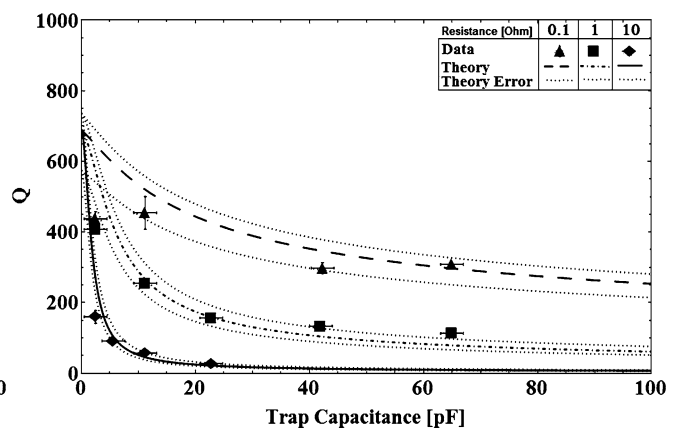
Figures 15 and 16 show that the experimental measurement of the  $Q$  factor and resonant frequency over a wide range of trap loads is consistent with the theory described in this work. The  $Q$  factor of resonator A can be seen to be higher than that of resonator B as it possesses specifications which are either optimal or nearer to optimal than resonator B (depending on the trap load applied). It can be seen that although the resonator is not optimal for the various ion trap impedances, the  $Q$  factor may still be sufficient for many experiments. This shows that a new resonator does not necessarily have to be built if the trap is altered slightly.

## 5 Experimental measurement of $\kappa$

It was shown in Sect. 2 that the voltage output of a resonator is given by  $V_{\text{rms}} = \kappa \sqrt{PQ}$ , where  $P$  is the power of the signal applied to the resonator,  $Q$  is the quality factor of the resonator and  $\kappa = (L/C)^{1/4}$ . Here we will experimentally measure the value of  $\kappa$  in an ion trap experiment. The value of  $\kappa$  is required in order to calculate the voltage applied to the ion trap electrodes used to create a trapping potential. A resonator, described in Table 3, was electrically connected to

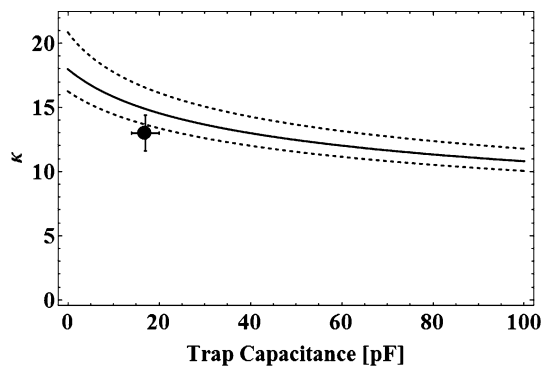
**Table 3** Specification of resonator used for  $\kappa$  measurements

Resonator	C
Shield diameter, $D$ [mm]	$76 \pm 1$
Shield height, $B$ [mm]	$105 \pm 1$
Coil diameter, $d$ [mm]	$52 \pm 2$
Coil wire diameter, $d_0$ [mm]	$4.0 \pm 0.1$
Winding pitch, $\tau$ [mm]	$7 \pm 3$
Number of turns, $N$	$7\frac{3}{4}$



shown by the triangles (0.1 ohm), squares (1 ohm) and diamonds (10 ohm)





**Fig. 17** The factor  $\kappa$  from (7) is plotted as a function of the trap capacitance for the resonator described in Sect. 5. The thick curve shows the value of  $\kappa$  with the dashed curves showing the error on this calculation due to the uncertainty of the resonator specifications and its imperfections. The data point shown is for the resonator attached to a  $17 \pm 3$  pF ion trap and vacuum system

an ion trap and vacuum system with a capacitance and resistance measured to be  $17 \pm 2$  pF and  $\approx 0.1$  ohm, respectively. The resonant frequency and  $Q$  was then measured with this additional load to be  $\omega_0 = 2\pi \times 21.895 \pm 0.010$  MHz and  $Q = 477 \pm 28$ , respectively.

A single  $^{174}\text{Yb}$  ion was trapped in the electric field created by the trap electrodes with the resonator supplied with  $1.0 \pm 0.1$  W at its resonant frequency. The secular frequencies of the ion under these conditions were then measured and a boundary element method (BEM) model of the trapping field was used to determine the RF voltage required to create such a field. This voltage was found to be  $400 \pm 20$  V which, when used in (7) along with the power used to trap the ion, results in a  $\kappa$  of  $12.9 \pm 1.4$ . This result is compared with the theoretical prediction of  $\kappa$  (from (7)) in Fig. 17. We note that the value of  $\kappa$  depends on the impedance of the ion trap attached to the resonator.

## 6 Conclusions

We have carried out a detailed study of helical resonators for the use in applying high voltages at radio frequencies to ion traps. This has been done by modelling the resonator as a lumped element circuit along with a detailed discussion on the losses present in helical resonators connected to ion trap loads in order to arrive at an expression for the  $Q$  factor and resonant frequency  $\omega_0$ . It has been shown how a resonator and load can be impedance matched to a frequency source by simply adjusting the physical parameters of an antenna coil which inductively couples the two. A general expression for the voltage output of the resonating system has been derived in terms of the systems  $Q$  factor, input power,  $P$ , and a  $\kappa$  factor which is a function of the systems capacitance and inductance. We have experimentally confirmed the value of this factor using a single trapped ion. The theory

described in this paper has been confirmed by fabricating two resonators and measuring their  $Q$  factor and resonant frequency,  $\omega_0$ , for a range of different trap loads ( $C_T$  from 2 pF to 85 pF and  $R_T$  from 0.1 to 10 ohm).

A detailed design guide has been presented showing how a helical resonator can be designed which provides the highest  $Q$  factor achievable for a desired resonant frequency within the constraints of an particular experiment. Producing a resonator with an optimised  $Q$  factor allows the application of high voltages with optimised filtering. This will result in less noise injected into the system which could reduce anomalous heating of the trapped ions. The application of high voltages can give larger trap depths, leading to longer trapping lifetimes and increased secular frequencies. This technology plays a significant role in many ion trapping experiments and should allow for progress in a variety of fields that require trapped ions or high radio frequency voltages.

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